

**JCWSCS 12 MAY 2004**  
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Norm Anderson

626-793-6685

P. 1

14139

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: ) Group Art Unit: 2131  
JOHN SILZEL et al. )  
Serial No.: 10/701,986 )  
Filing Date: November 4, 2003 )  
For: IMPROVED ACCURACY ARRAY )  
ASSAY SYSTEM AND METHOD )  
) CERTIFICATE OF TRANSMISSION UNDER 37 CFR 1.8  
I hereby certify that this correspondence is being facsimile  
transmitted to the United States Patent and Trademark Office  
(703-746-9195) on 5-12-04  
Kira Lutchenkov  
Kira Lutchenkov

**REQUEST FOR CORRECTED FILING RECEIPT**

Commissioner of Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

Please issue a corrected filing receipt for this application.

Enclosed is a marked up copy of the "Updated Filing Receipt" mailed April 22, 2004. The title of the invention is "Improved Accuracy Array Assay System and Method." The term "improved" was left off the title.

Respectfully submitted  
SHELDON & MAK PC

Dated: 5-12-04

By

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## UNITED STATES PATENT AND TRADEMARK OFFICE

UNITED STATES DEPARTMENT OF COMMERCE  
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APPL NO.	FILING OR 371 (c) DATE	ART UNIT	FIL FEE REC'D	ATTY.DOCKET NO	DRAWINGS	TOT CLMS	IND CLMS
10/701,986	11/04/2003	2131	1646	14139	4	28	6

## CONFIRMATION NO. 8197

23676  
 SHELDON & MAK, INC  
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## UPDATED FILING RECEIPT



\*OC000000012416853\*

Date Mailed: 04/22/2004

Receipt is acknowledged of this regular Patent Application. It will be considered in its order and you will be notified as to the results of the examination. Be sure to provide the U.S. APPLICATION NUMBER, FILING DATE, NAME OF APPLICANT, and TITLE OF INVENTION when inquiring about this application. Fees transmitted by check or draft are subject to collection. Please verify the accuracy of the data presented on this receipt. If an error is noted on this Filing Receipt, please write to the Office of Initial Patent Examination's Filing Receipt Corrections, facsimile number 703-746-9195. Please provide a copy of this Filing Receipt with the changes noted thereon. If you received a "Notice to File Missing Parts" for this application, please submit any corrections to this Filing Receipt with your reply to the Notice. When the USPTO processes the reply to the Notice, the USPTO will generate another Filing Receipt incorporating the requested corrections (if appropriate).

## Applicant(s)

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## Domestic Priority data as claimed by applicant

## Foreign Applications

If Required, Foreign Filing License Granted: 02/13/2004

Projected Publication Date: 05/05/2005

Non-Publication Request: No

Early Publication Request: No

Title *a*  
 IMPROVED Accuracy array assay system and method

## Preliminary Class